

STUSB02E

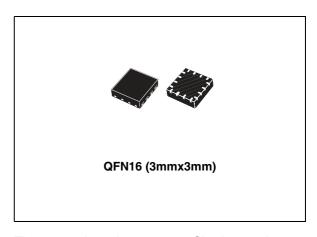
USB Transceiver

General features

- Supports 1.5Mbps and 12Mbps serial data transmission
- ESD HBM: ±14kV on D+, D- Lines; ±5kV on VBUS
- ESD Compliant to IEC-61000-4.2 (Level 3)
- Separate I/O supply with operation down to 1 6V
- Integrated speed select termination supply
- Very low power consumption to meet USB 'suspend' current requirements
- Small QFN16 lead free package
- No power supply sequencing requirements
- Software controlled re-enumeration

Description

The STUSB02E is a single chip USB transceiver that supports both full-speed (12Mbps) and low-speed (1.5Mbps) operation. It has an integrated 5V to 3.3V regulator which allows direct powering from the V_{BUS} . The transceiver has an integrated voltage detector to detect the presence of the V_{BUS} voltage.



The transceiver also supports Sharing mode when V_{BUS} is not present, which allows the D+/D-lines to be shared with other serial protocols.

It is also designed to operate down to 1.6V so that it is compatible with lower system voltages of most portable systems, which include PDAs, MP3 Player and Cell phones.

Order code

Part number	Package	Packaging
STUSB02EQR	QFN16 (3mm x 3mm)	3000 parts per reel

Contents STUSB02E

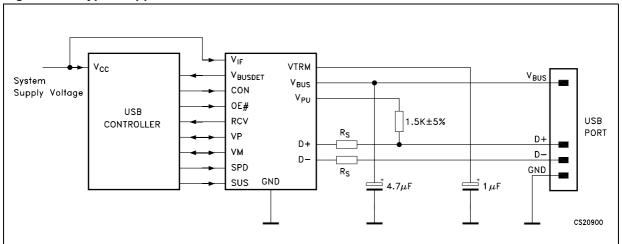
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STUSB02E Typical application

1 Typical application

Figure 1. Typical application



Pin configuration STUSB02E

2 Pin configuration

Figure 2. Pin connections (top view)

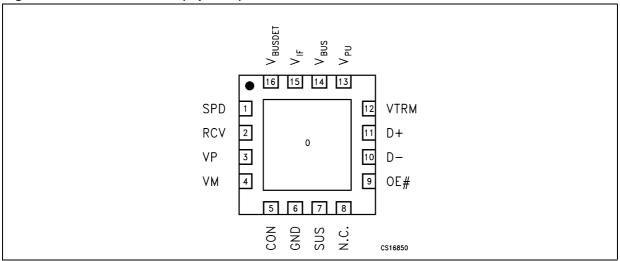


Table 1. Pin description

PIN N°	SYMBOL	I/O	NAME AND FUNCTION
0	N.C.		Not Connected.
15	V _{IF}	1	System Interface Supply Voltage (1.6V to 3.6V). Provides reference supply voltage for system I/O interface signals.
1	SPD	I	Edge Rate Control. A logic HIGH operates at edge rates for "fullspeed" operation. A logic LOW operates edge rates for "lowspeed" operation.
2	2 RCV O Receive Data. Output for USB differential data. (see <i>Table 2</i>)		Receive Data. Output for USB differential data. (see <i>Table 2</i>)
3	VP	I/O	If OE# = H, VP = Receiver output (+) If OE# = L, VP = Driver input (+) (see <i>Table 2</i>)
4	VM	I/O	If OE# = H, VM = Receiver output (-) If OE# = L, VM = Driver input (-) (see <i>Table 2</i>)
5	CON	ı	CONNECT (input). Controls state of V_{PU} . Refer to V_{PU} pin description for detail.
6	GND		Ground Reference
7	SUS	ı	Suspend (active-high). Turns off internal circuits to reduce supply current.
9	OE#	1	Output Enable (active-low). Enables transceiver data transmission onto the bus. When not active, the transceiver is in the receive mode. (see <i>Table 2</i>)
10, 11	D-, D+	I/O	Differential data lines. (see <i>Table 2</i>)
12	VTRM	0	3.3V Reference Supply Output. Requires a 1.0µF decoupling capacitor for stability.
13	V _{PU}	0	Pull-up Supply Voltage Output. Used to connect $1.5 \mathrm{k}\Omega$ pull-up speed detect resistor. If CON = 0, V_{PU} is high impedance. If CON = 1, V_{PU} = 3.3V ±10%.
14	V _{BUS}	I	USB Bus Supply Voltage (4V to 5.5V). Supplies power to the USB transceiver and internal circuitry.
8	N.C.		Not connected.
16	V _{BUSDET}	0	V_{BUS} indicator output. When V_{BUS} > 2.9V, V_{BUSDET} = High and when < 2.2V, V_{BUSDET} = Low.

STUSB02E Functional tables

3 Functional tables

Table 2. Function selection

SUS	OE#	D+, D-	RCV	VP/VM	Function
L	L	Driving	Active	Active	Normal transmit mode
L	Н	Receiving	Active	Active	Normal receive mode
Н	L	Hi-Z	L	Not Active	Low power state
Н	Н	Hi-Z	L	Active	Receiving during suspend (low power state) (1)

⁽¹⁾ During suspend VP and VM are active in order to detect out of band signalling conditions

Table 3. Truth table during normal mode

)E# = L					
Input		Output			DECLUT
VP	VM	D+	D-	RCV	RESULT
L	L	L	L	X	SE0
L	Н	L	Н	L	Logic Low
Н	L	Н	L	Н	Logic High
Н	Н	Χ	Х	Х	Undefined
E# = H					
Inj	put		Output		Dooule
D+	D-	VP	VM	RCV	Result
L	L	L	L	X	SE0
L	Н	L	Н	L	Logic Low
Н	L	Н	L	Н	Logic High
Н	Н	Χ	X	Х	Undefined

X = Undefined

Maximum ratings STUSB02E

4 Maximum ratings

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{BUS}	Supply voltage	6	V
V+	All other Inputs	-0.5 to 4.6	V
Ιο	Output current (D+, D-)	±50	mA
Io	Output current (all others)	± 15	mA
l _l	Input current	±50	mA
	D+, D-, HBM (Note 3)	± 14	
ESD	V _{BUS} (Note 3)	±5	kV
	All other pins (Note 3)	±2	
T _{STG}	Storage temperature range	-65 to + 150	°C
T _{OPR}	Operating temperature range	-40 to + 85	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional Operation under these conditions is not implied.

Note 3. Devices are ESD sensitive. Handling precautions recommended. Human body model, $1.5k\Omega$ in series with 100pF.

Table 5. Thermal data

Symbol	Parameter	Value	Unit
R _{thJA}	Thermal resistance junction-ambient	59	°C/W

STUSB02E Electrical characteristics

5 Electrical characteristics

Table 6. DC electrical characteristics (System and USB interface)

(V_{IF} = 3.6V, V_{BUS} = 5V unless otherwise noted; T_A = 25°C, specifications over temperature, -40 to 85°C)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
V _{BUS}	USB Supply voltage		4		5.5	V	
V _{IF}	System I/F supply voltage		1.6		3.6	٧	
V _{IL}	Low level input voltage (Note 4)				0.15V _{IF}	٧	
V_{IH}	High level input voltage (Note 4)		0.85V _{IF}			V	
V _{OL}	Low level output voltage (Note 4)	I _{OL} = 20μA	0		100	mV	
V _{OH}	High level output voltage (Note 4)	I _{OH} = -20μA	V _{IF} -100		V _{IF}	mV	
I _{IL}	Input leakage current (Note 4)		-5		5	μΑ	
		D+, D- are idle, OE# = SUS = 0			5		
		D+, D- are idle, $OE# = SUS = 1$			5		
I _{IF}	V _{IF} Supply current (Note 7)	D+, D- active, $C_{LOAD} = 50pF$,			650	μA	
		SPD = 1, f = 6MHz, (Note 5) D+, D- active, C _{LOAD} = 600pF,				-	
		SPD = 0, f = 750KHz, (Note 5)			75		
		D+, D- are idle, $V_{BUS} = 5.25V$					
		Suspend Mode (SUS = 1), OE# =			200	μA	
		1, SPD = 1				-	
		D+, D- are idle, V _{BUS} = 5.25V			5	mA	
		SPD = 1, OE# = SUS = 0			5		
		D+, D- are idle, $V_{BUS} = 5.25V$			700		
		OE# = SUS = SPD = 0			700	μA	
I _{BUS}	V _{BUS} Supply current	D+, D- are idle, $V_{BUS} = 5.25V$			350	μ, ι	
		OE# = 1, SUS = SPD = 0					
		D+, D- active, V _{BUS} = 5.25V					
		$C_{LOAD} = 50$ pF, SPD = 1, f = 6 MHz			10		
		OE# = SUS = 0 (Note 5)				mA	
		D+, D- active, V _{BUS} = 5.25V			_		
		$C_{LOAD} = 600 \text{pF}, f = 750 \text{ KHz},$			5		
lunu e · · ·	V _{PU} Leakage current	OE# = SUS = SPD = 0 (Note 5) CON = 0, V _{PU} = 0V	-5		5		
Ivpuleak	V _{IF} Leakage current	$V_{IF} = 3.6V, V_{BUS} = 0V$	-5 -5		5	μΑ	
I _{VIFLEAK}	" -	$I_{TERM} = 200\mu A, V_{BUS} = 4 \text{ to } 5.25V$	-5 3			μA V	
V _{PU}	Pull-Up output voltage				3.6	•	
R _{SW}	V _{PU} Internal switch resistance	$I_{TERM} = 10$ mA, $V_{BUS} = 4$ to 5.25V	7	9	11	Ω	

Note 1. Exceeding the absolute maximum rating may damage the device.

Note 2. The device is not guaranteed to function outside its operating rating.

Note 3. Devices are ESD sensitive. Handling precautions recommended. Human body model, $1.5k\Omega$ in series with 100pF.

Note 4. Specification applies to the following pins: SUS, SPD, RCV, CON, VP, VM, OE#, VBUSDET.

Note 5. Characterized specification(s), but not production tested.

Note 6. All AC parameters guaranteed by design but not production tested.

Note 7. RCV NOT LOADED

STUSB02E Electrical characteristics

Table 7. DC electrical characteristics (System and USB interface)

 $(V_{IF} = 3.6V, V_{BUS} = 5V \text{ unless otherwise noted; } T_A = 25^{\circ}C)$

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V_{BUS}	USB Supply voltage		4		5.5	V
V_{IF}	System I/F supply voltage		1.6		3.6	V
V_{IL}	Low level input voltage (Note 4)				0.15V _{IF}	V
V_{IH}	High level input voltage (Note 4)		$0.85V_{IF}$			V
V _{OL}	Low level output voltage (Note 4)	I _{OL} = 20μA			0.1	V
V _{OH}	High level output voltage (Note 4)	Ι _{ΟΗ} = 20μΑ	0.9V _{IF}			V
I _{IL}	Input leakage current (Note 4)		-5		5	μΑ
		D+, D- are idle, OE# = SUS = 0			5	
l _{IF}	V _{IF} Supply current (Note 7)	D+, D- active, $C_{LOAD} = 50pF$, SPD = 1, f = 6MHz, (Note 5)		450		μΑ
		D+, D- active, C _{LOAD} = 50pF,		50		
		SPD = 0, f = 750KHz, (Note 5)		50		
	V _{BUS} Supply current	D+, D- are idle, V _{BUS} = 5.25V		70	150	μA
		Suspend Mode (SUS = 1)		70	100	μΛ
		D+, D- are idle, V _{BUS} = 5.25V		3.0		mA
		SPD = 1, OE# = SUS = 0				
		D+, D- are idle, $V_{BUS} = 5.25V$ OE# = SUS = SPD = 0		300		
I _{BUS}		D+, D- are idle, V _{BUS} = 5.25V OE# = 1, SUS = SPD = 0		150		μA
		D+, D- active, V _{BUS} = 5.25V				
		$C_{LOAD} = 50pF, SPD = 1, f = 6 MHz$		7.3		
		OE# = SUS = 0 (Note 5)		7.0		
		D+, D- active, V _{BUS} = 5.25V				mA
		C _{LOAD} = 600pF, f = 750 KHz,		3.6		
		OE# = SUS = SPD = 0 (Note 5)				
I _{VPULEAK}	V _{PU} Leakage current	CON = 1, V _{PU} = 0V	-5		5	μΑ
I _{VIFLEAK}	V _{IF} Leakage current	V _{IF} = 3.6V, V _{BUS} = 0V	-5		5	μA
V _{PU}	Pull-Up output voltage	$I_{TERM} = 200\mu A$, $V_{BUS} = 4$ to 5.25V		3.3		٧
R _{SW}	V _{PU} Internal switch resistance	I _{TERM} = 10mA, V _{BUS} = 4 to 5.25V		9		Ω

Note 1. Exceeding the absolute maximum rating may damage the device.

Note 2. The device is not guaranteed to function outside its operating rating.

Note 3. Devices are ESD sensitive. Handling precautions recommended. Human body model, 1.5kΩ in series with 100pF.

Note 4. Specification applies to the following pins: SUS, SPD, RCV, CON, VP, VM, OE#, VBUSDET.

Note 5. Characterized specification(s), but not production tested.

Note 6. All AC parameters guaranteed by design but not production tested.

Note 7. RCV NOT LOADED

Table 8. **ESD Performance**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
ESD	-(;-1()()()-4-2 ()+)-)	Air discharge (10 pulses)		±8		
		Contact discharge (10 pulses)		±6		kV
	TEC-1000-4-2 (Valid ONV)	Air discharge (10 pulses)		±5		ΝV
		Contact discharge (10 pulses)		±5		

STUSB02E Electrical characteristics

DC electrical characteristics (Transceiver) Table 9.

 $(V_{IF} = 3.6V, V_{BUS} = 5V \text{ unless otherwise noted}; T_A = 25^{\circ}\text{C}, \text{ specifications over temperature},$ -40 to 85°C)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{LO}	Hi-Z State data line leakage (suspend mode)	V _I = 0 to 3.3 V, SUS = 1	-10		10	μΑ
V_{DI}	Differential input sensitivity	l(D+) - (D-)l	0.2			V
V _{CM}	Differential common mode range	Includes V _{DI} range	0.8		2.5	V
V_{SE}	Single ended receiver threshold		0.8		2.0	V
V _{RHYS}	Receiver hysteresis	V _{CM} = 0.8 V		100		mV
V _{OL}	Static output low	$R_L = 1.5 \text{ K}\Omega \text{ at } 3.6 \text{V (see test circuit)}$			0.3	V
V _{OH}	Static output high	$R_L = 15 \text{ K}\Omega \text{ at GND (see test circuit)}$	2.8		3.6	V
CI	Transceiver capacitance	Pin to GND		25		pF
Z _{DRV}	Driver output resistance	Steady state drive	9		22	Ω

Table 10. DC electrical characteristics (Transceiver) $(V_{IF}=3.6V,\,V_{BUS}=5V\,\,\text{unless otherwise noted;}\,\,T_{A}=25^{\circ}C)$

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{LO}	Hi-Z state data line leakage (suspend mode)	V _I = 0 to 3.3 V, SUS = 1	-2		2	μΑ
V_{DI}	Differential input sensitivity	l(D+) - (D-)l	0.2			V
V _{CM}	Differential common mode range	Includes V _{DI} range	0.8		2.5	V
V _{SE}	Single ended receiver threshold		0.8		2	V
V _{RHYS}	Receiver hysteresis	V _{CM} = 0.8 V		50		mV
V _{OL}	Static output low	$R_L = 1.5 \text{ K}\Omega \text{ at } 3.6\text{V}$ (see <i>Test circuits</i>)			0.3	V
V _{OH}	Static output high	$R_L = 15 \text{ K}\Omega \text{ at GND}$ (see <i>Test circuits</i>)	2.8		3.6	V
C _I	Transceiver Capacitance (3)	Pin to GND		25		pF
Z _{DRV}	Driver Output Resistance	Steady state drive		16		Ω

⁽³⁾ Pins D+, D-

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Electrical characteristics STUSB02E

Table 11. AC electrical characteristics

(V $_{IF}$ = 3.6V, V $_{BUS}$ = 5V unless otherwise noted; T $_{A}$ = 25 $^{\circ}C.)$ (Note 6)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit	
T _R	Transition Dies Times (LOW CDEED)	C _L = 50pF (<i>Figure 4</i>) 75			ne		
	Transition Rise Time (LOW SPEED)	C _L = 600pF			300	ns	
T _F	Transition Fall Time (LOW SPEED)	C _L = 50pF (<i>Figure 4</i>)	75			ns	
		C _L = 600pF			300		
T _{R,} T _F	Rise/Fall Time Matching (LOW SPEED)	(T _R , T _F)	80		125	%	
V _{CRS}	Output Signal Crossover Voltage (LOW SPEED)		1.3		2	V	
T _R	Transition Rise Time (FULL SPEED)	C _L = 50pF (<i>Figure 4</i>)	4		20	ns	
T _F	Transition Fall Time (FULL SPEED)	C _L = 50pF (<i>Figure 4</i>)	4		20	ns	
T _R , T _F	Rise/Fall Time Matching (FULL SPEED)	(T _R , T _F)	90		111.11	%	
V _{CRS}	Output Signal Crossover Voltage (FULL SPEED)		1.3		2	V	
t _{PVZ}	OE# TO RCVR Tri-State Delay	Figure 3		3		ns	
tozo	Receiver Iri-State to Transmit Delay	LOW SPEED (Figure 3)	13			ns	
t _{PZD}		FULL SPEED (Figure 3)	32			113	
t _{PDZ}	OE# TO RCVR Tri-State Delay	Figure 3		6		ns	
t _{PZV}	Driver Tri-State to Receive Delay	Figure 3		27		ns	
t _{PLH} t _{PHL}	VP, VM to D+, D- Propagation Delay	Figure 6		16	20	ns	
t _{PLH} t _{PHL}	D+, D- to RCV Propagation Delay	Figure 5		13	20	ns	
t _{PLH} t _{PHL}	D+, D- to VP, VM Propagation Delay	Figure 5		8	20	ns	

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Note 2. The device is not guaranteed to function outside its operating rating.

Note 3. Devices are ESD sensitive. Handling precautions recommended. Human body model, $1.5k\Omega$ in series with 100pF.

Note 4. Specification applies to the following pins: SUS, SPD, RCV, CON, RCV, VP, VM, OE#.

Note 5. Characterized specification(s), but not production tested.

Note 6. All AC parameters guaranteed by design but not production tested.

STUSB02E Timing diagram

6 Timing diagram

Figure 3. Enable and disable times

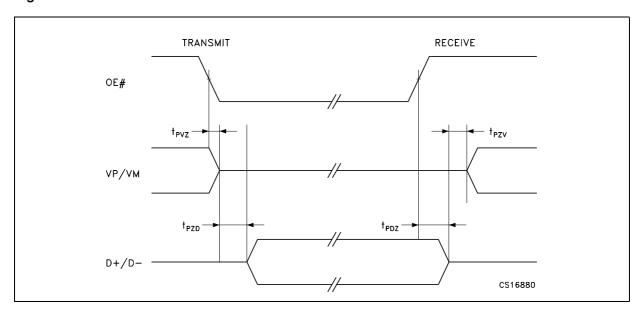
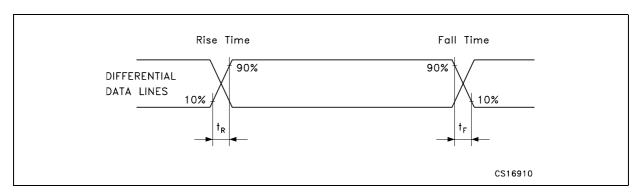


Figure 4. Rise and fall times



Timing diagram STUSB02E

Figure 5. Receiver propagation delay

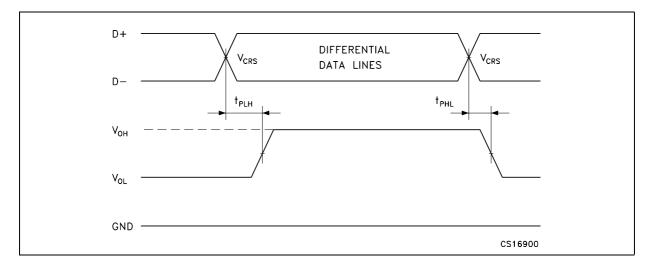
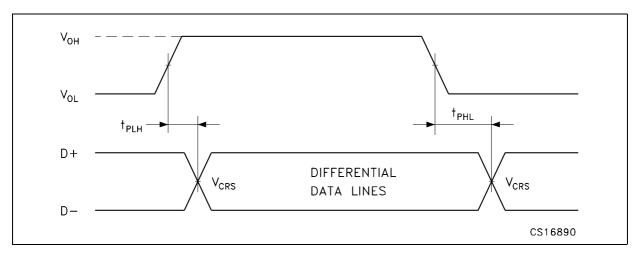
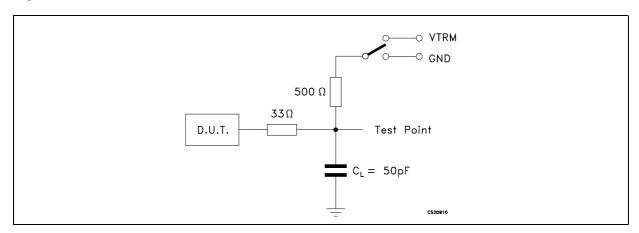


Figure 6. Driver propagation delay ($C_L = 50pF$)



Minimum Timing LS and maximum timing FS

Figure 7. Enable and disable time circuit



Switch = GND for t_{PZH} and t_{PHZ} ; V = VTRM for t_{PZL} and t_{PLZ}

STUSB02E Test circuits

7 Test circuits

Figure 8. Load for VP, VM, RCV

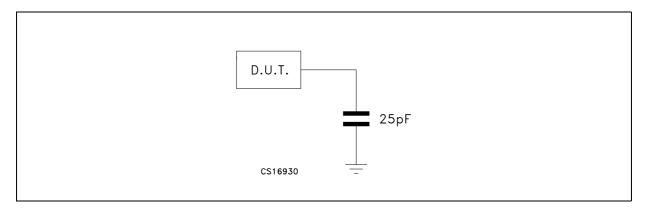
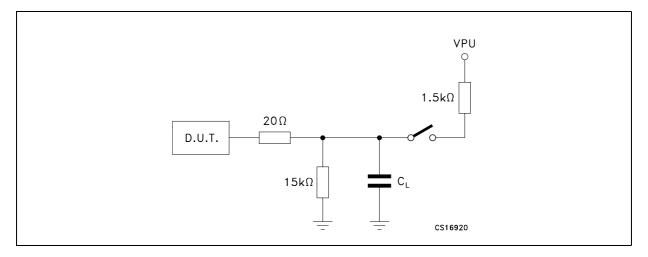
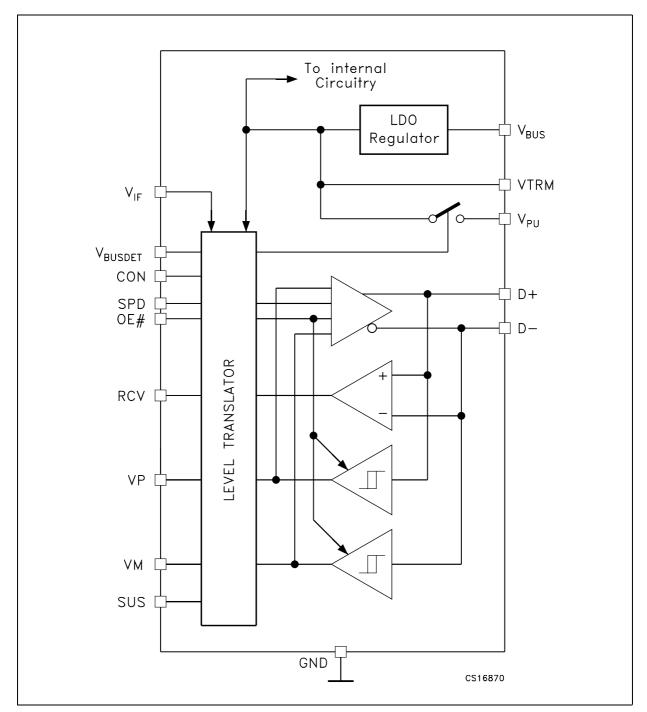


Figure 9. Load for D+, D-



Test circuits STUSB02E

Figure 10. Functional diagram



STUSB02E Functional description

8 Functional description

The STUSB02E is designed to provide USB connectivity in mobile systems where available system supply voltages are not able to satisfy USB requirements. The STUSB02E can operate down to supply voltages of 1.6V. As shown in the circuit above, the STUSB02E takes advantage of the USB supply voltage, V_{BUS} , to operate the transceiver. The system voltage, V_{IF} is used to set the reference voltage used by the digital I/O lines interfacing to the system controller. Internal circuitry provides translation between the USB and system voltage domains. V_{IF} will typically be the main supply voltage rail for the controller.

In addition, a 3.3V, 10% termination supply voltage, V_{PU} , is provided to support speed selection. V_{PU} can be disabled or enabled under software control via the CON input. This allows for software-controlled connect or disconnect states. A 1.5K Ω resistor is required to be connected between this pin and the D+ or D– lines to respectively specify full speed or low speed operation.

The use of ESD transient protection devices is not required for operation, but is recommended.

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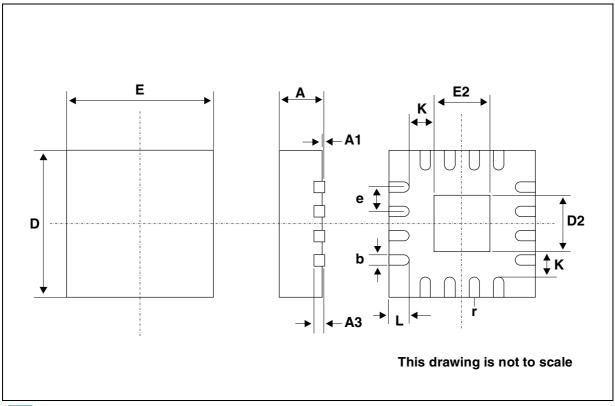
Package mechanical data STUSB02E

9 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK[®] packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

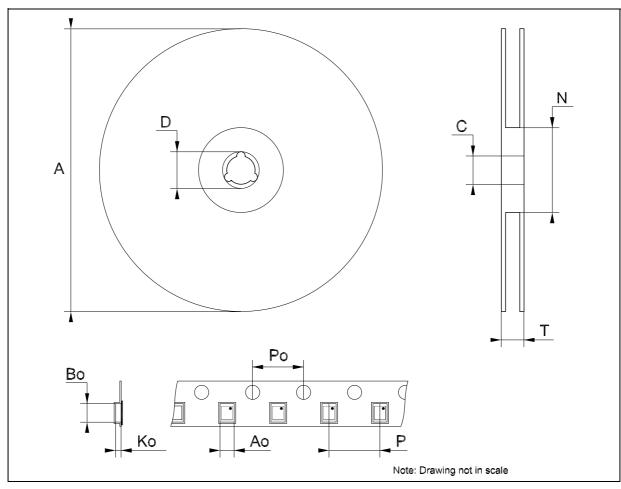
QFN16 (3mmx3mm) MECHANICAL DATA

DIM	mm.			inch			
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
Α	0.80	0.90	1.00	0.032	0.035	0.039	
A1		0.02	0.05		0.001	0.002	
А3		0.20			0.008		
b	0.18	0.25	0.30	0.007	0.010	0.012	
D		3.00			0.118		
D2	1.55	1.70	1.80	0.061	0.067	0.071	
E		3.00			0.118		
E2	1.55	1.70	1.80	0.061	0.067	0.071	
е		0.50			0.020		
К		0.20			0.008		
L	0.30	0.40	0.50	0.012	0.016	0.020	
r	0.09			0.006			



Tape & Reel QFNxx/DFNxx (3x3) MECHANICAL DATA

DIM	mm.			inch			
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
Α			330			12.992	
С	12.8		13.2	0.504		0.519	
D	20.2			0.795			
N	60			2.362			
Т			18.4			0.724	
Ao		3.3			0.130		
Во		3.3			0.130		
Ko		1.1			0.043		
Ро		4			0.157		
Р		8			0.315		



STUSB02E Revision history

10 Revision history

Table 12. Revision history

Date Revision		Changes			
19-Oct-2005	1	First Release.			
21-Feb-2006 2		Declaration of conformity with USB 2.0 specification removed.			
07-Apr-2006 3		Corrected wrong links to figures in table 11.			
14-Mar-2007	4	Update tape & reel.			

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